

# Modeling superconducting inhomogeneities of commercial REBCO tapes with a 1-D electro-thermal model comparing two different constitutive laws

Nicolò Riva (**EPFL, MIT**), Francesco Grilli (**KIT**), Bertrand Dutoit (**EPFL**)

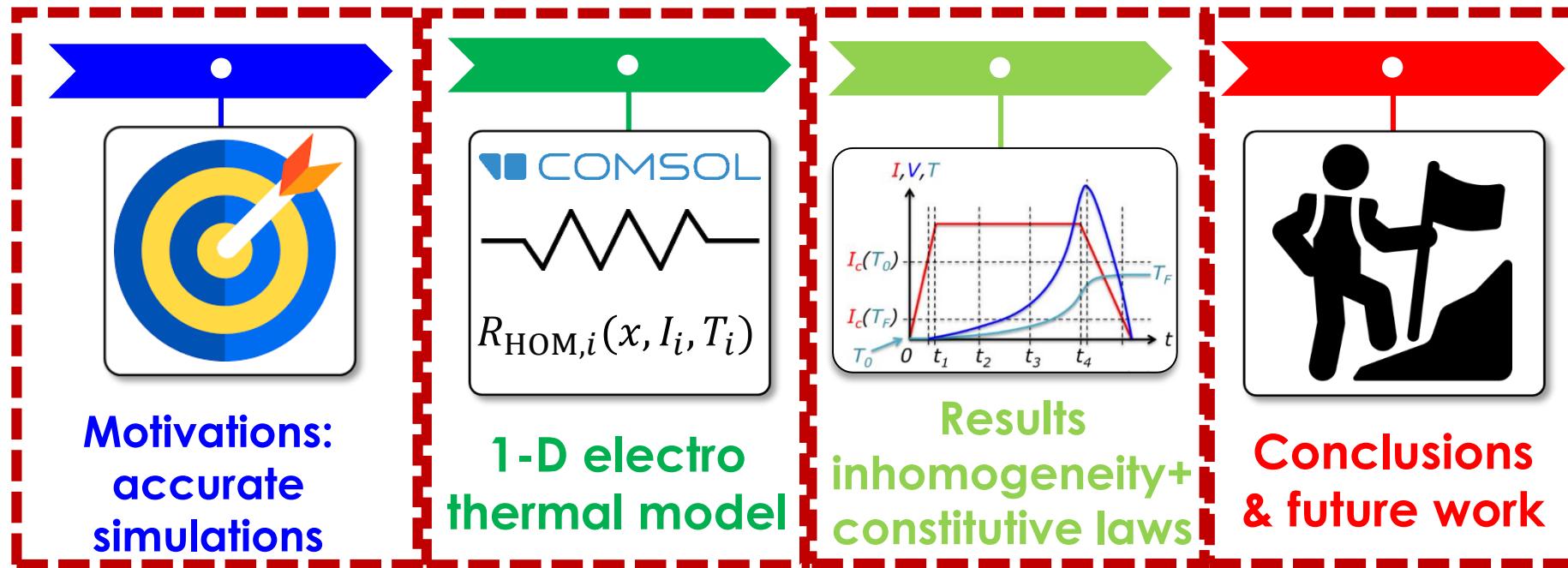


**EPFL**

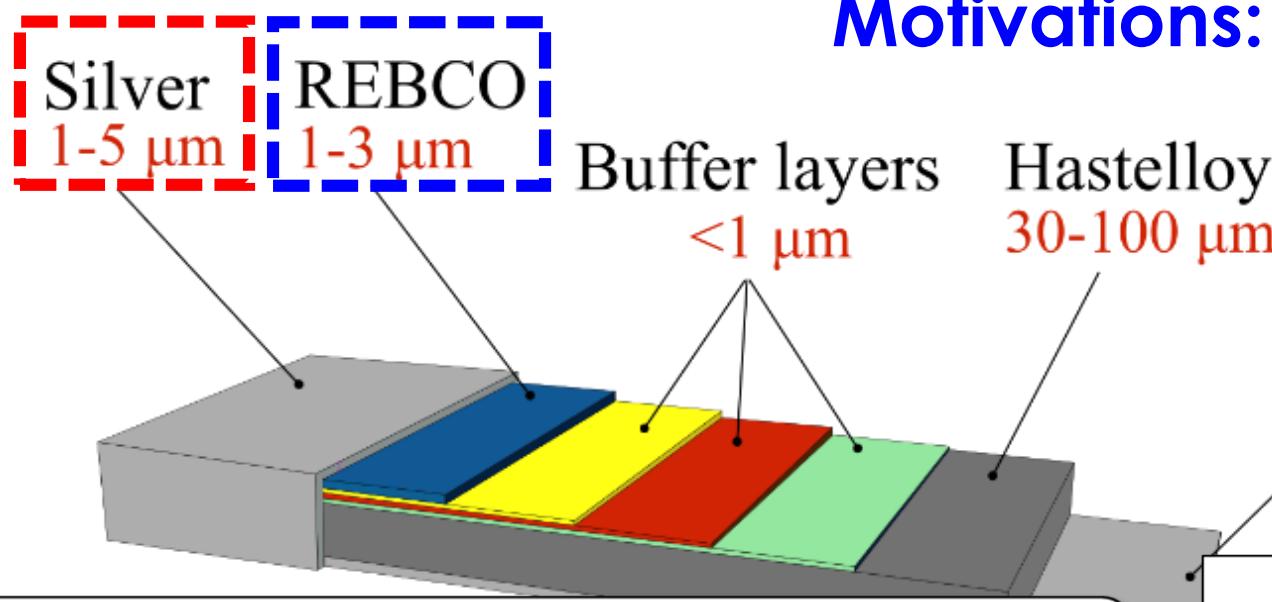
**KIT**  
Karlsruhe Institute of Technology

**MIT PSFC**

# Outline



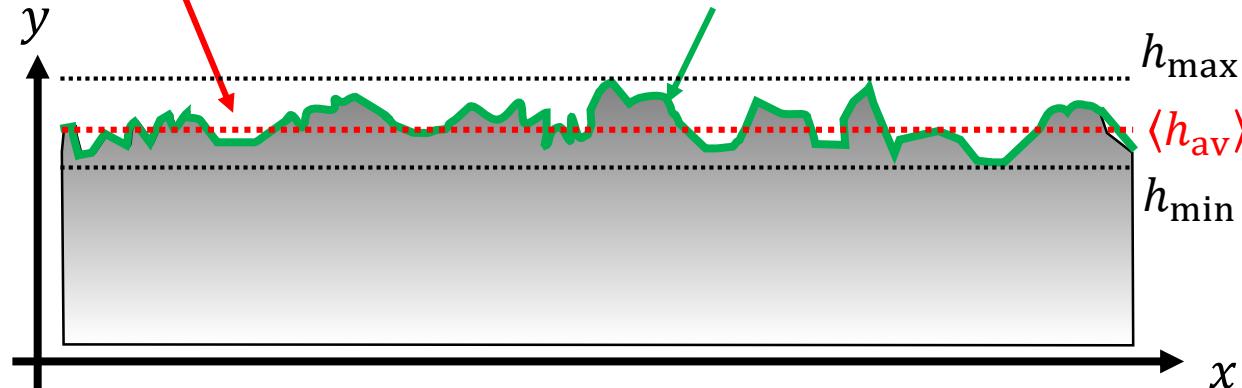
# Motivations: accurate simulations



Silver  
1-5  $\mu\text{m}$

Nominal thickness

Real profile

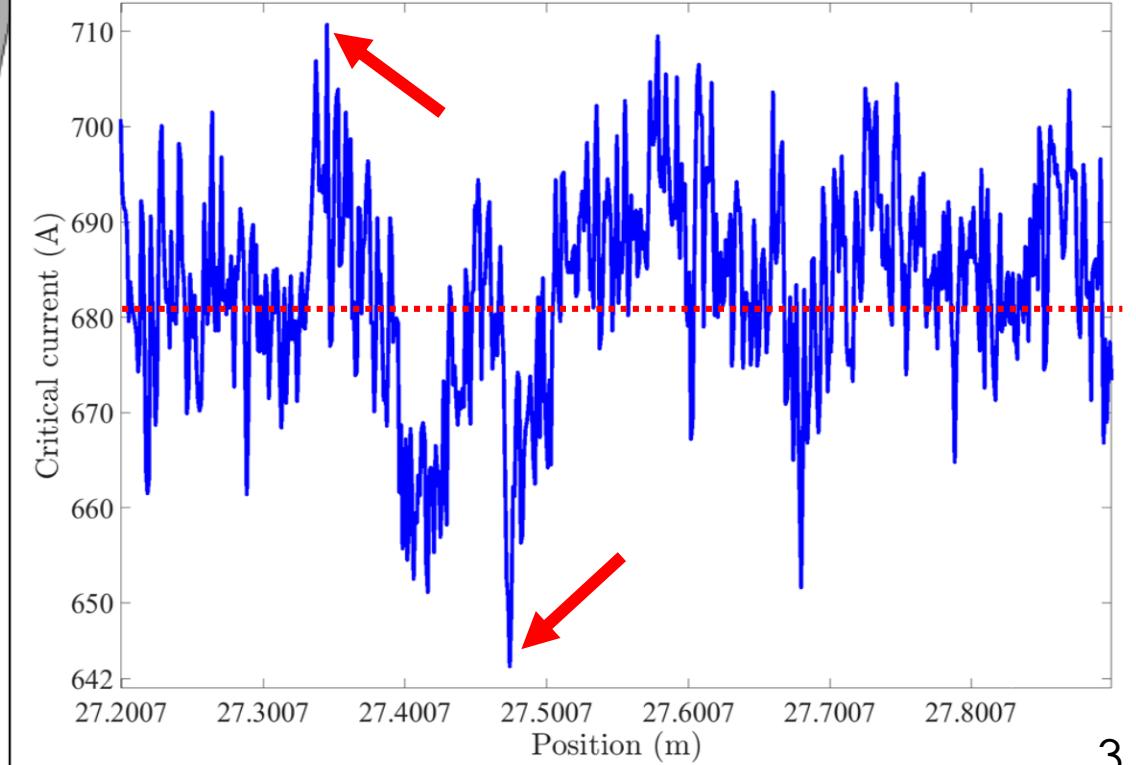


REBCO  
1-3  $\mu\text{m}$

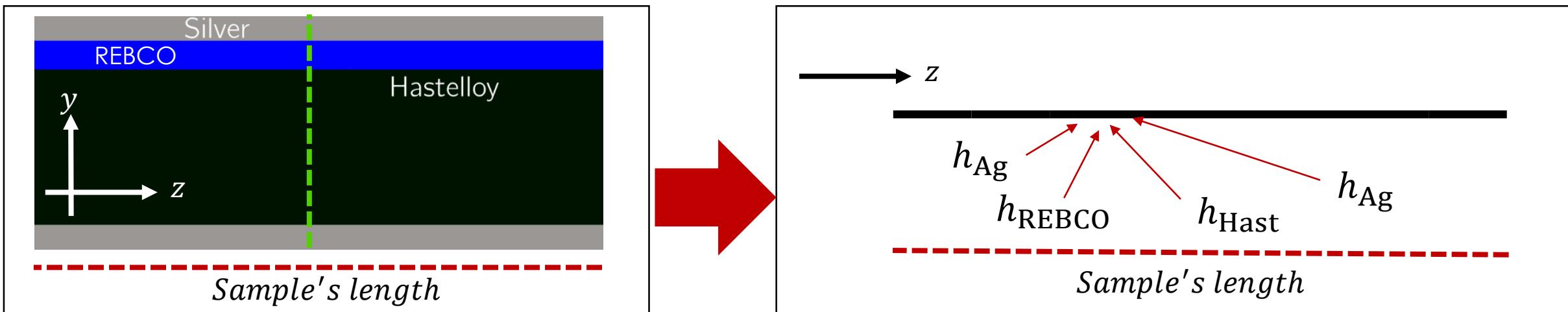
Buffer layers  
<1  $\mu\text{m}$

Hastelloy  
30-100  $\mu\text{m}$

Silver  
1-5  $\mu\text{m}$



# Step 1: Homogenized Heat Equation



## Heat equation

$$\rho_{m,\text{HOM}}(T) C_{p,\text{HOM}}(T) \frac{\partial T(z, t)}{\partial t} + \frac{\partial}{\partial z} \left( -k_{\text{HOM}}(T) \frac{\partial T(z, t)}{\partial z} \right) = Q$$

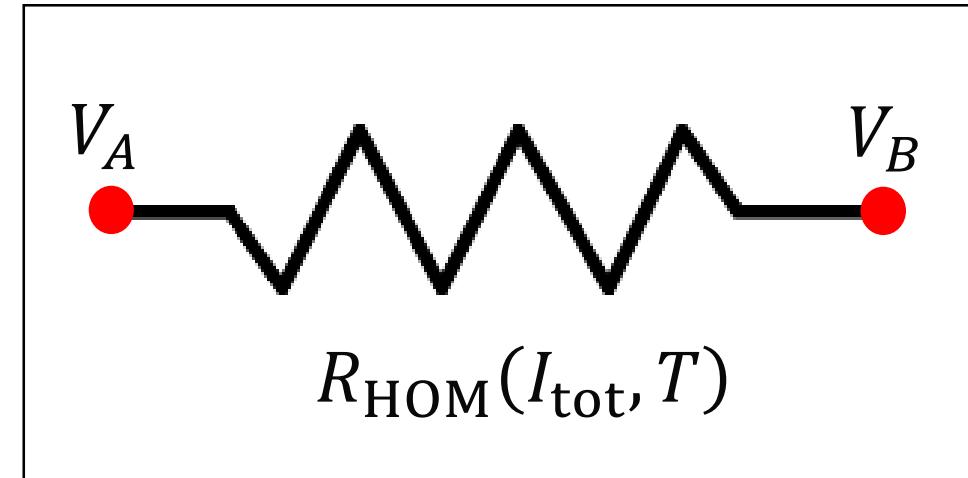
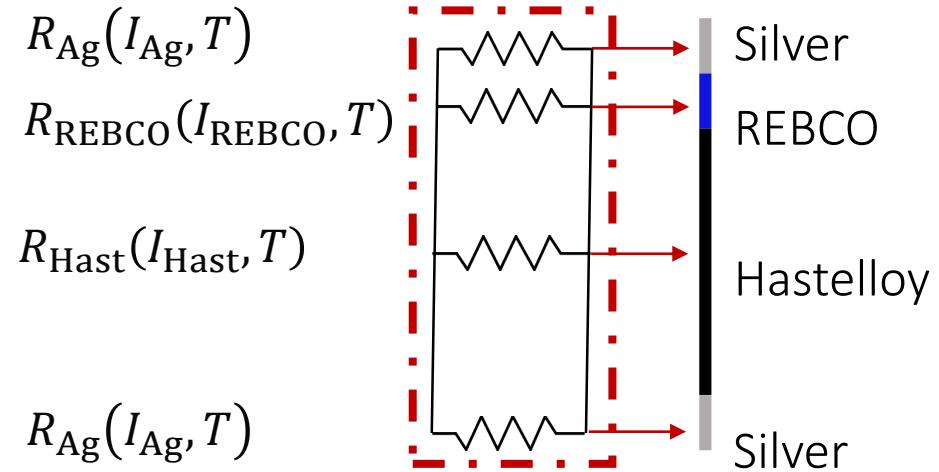
$$Q = EJ - \frac{2h \cdot (T - T_0)}{h_{\text{tot}}}$$

$$\rho_{m,\text{HOM}}(T) = \frac{\sum Vol_j \rho_{m,j}}{Vol_{\text{tape}}}$$

$$C_{p,\text{HOM}}(T) = \frac{\sum m_j C_{p,j}}{m_{\text{tot}}}$$

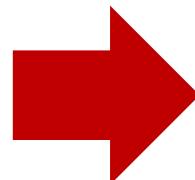
$$k_{\text{HOM}}(T) = \frac{\sum h_j k_j}{h_{\text{tot}}}$$

## Step 2: Equivalent electric circuit for tapes



## Electric circuit

$$I_j(T) = \frac{V_B - V_A}{R_i(I_i, T)}$$



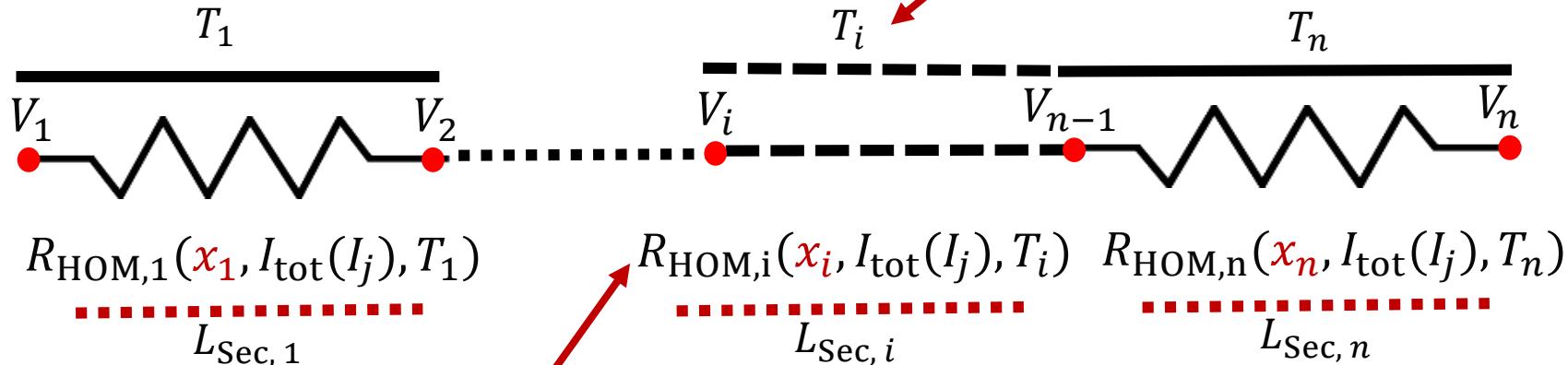
$$R_i(I_i, T) = \frac{\rho_{\text{el},i}(I_i, T) \cdot L}{S_i}$$

$$\frac{1}{R_{\text{HOM}}(I_{\text{tot}}(I_j), T)} = \sum \frac{1}{R_j(I_j, T)}$$

$$I_{\text{REBCO}}(t) = I_{\text{tot}}(t) - \sum_{j=1}^{n_{\text{mat}}} I_j(t)$$

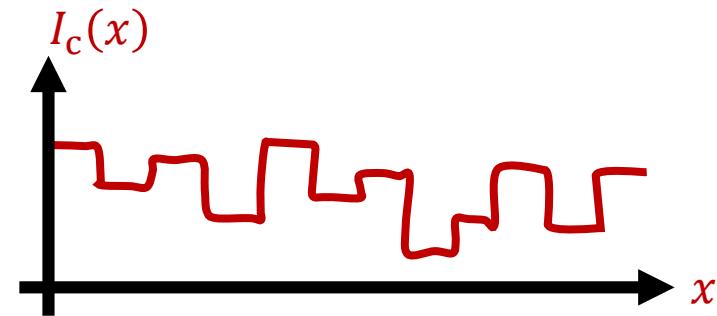
# Step 3: 1-D electrothermal model

1-D Homogenized Heat  
Equation for  $n$  sections

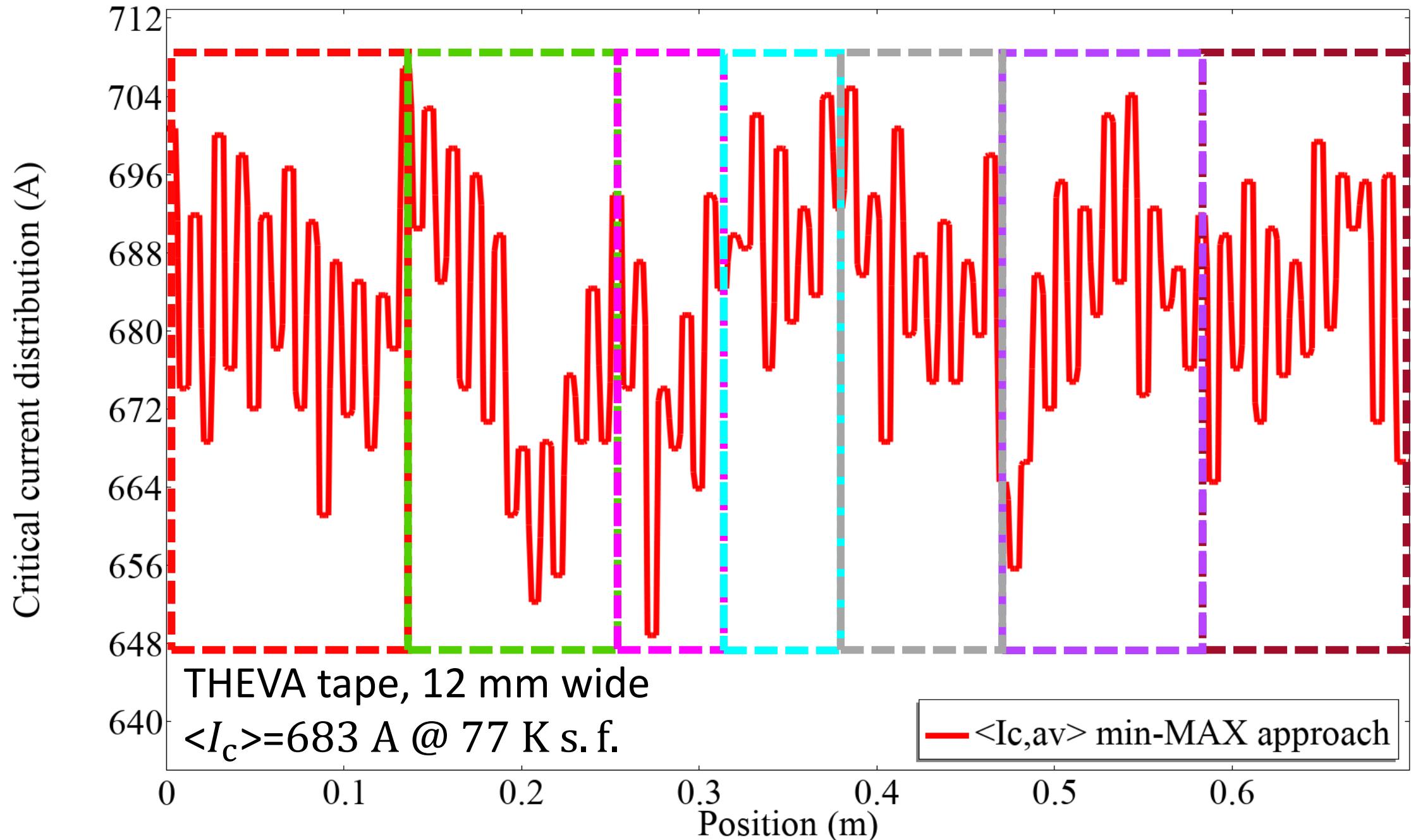


Equivalent electric  
circuit for  $n$  short tapes

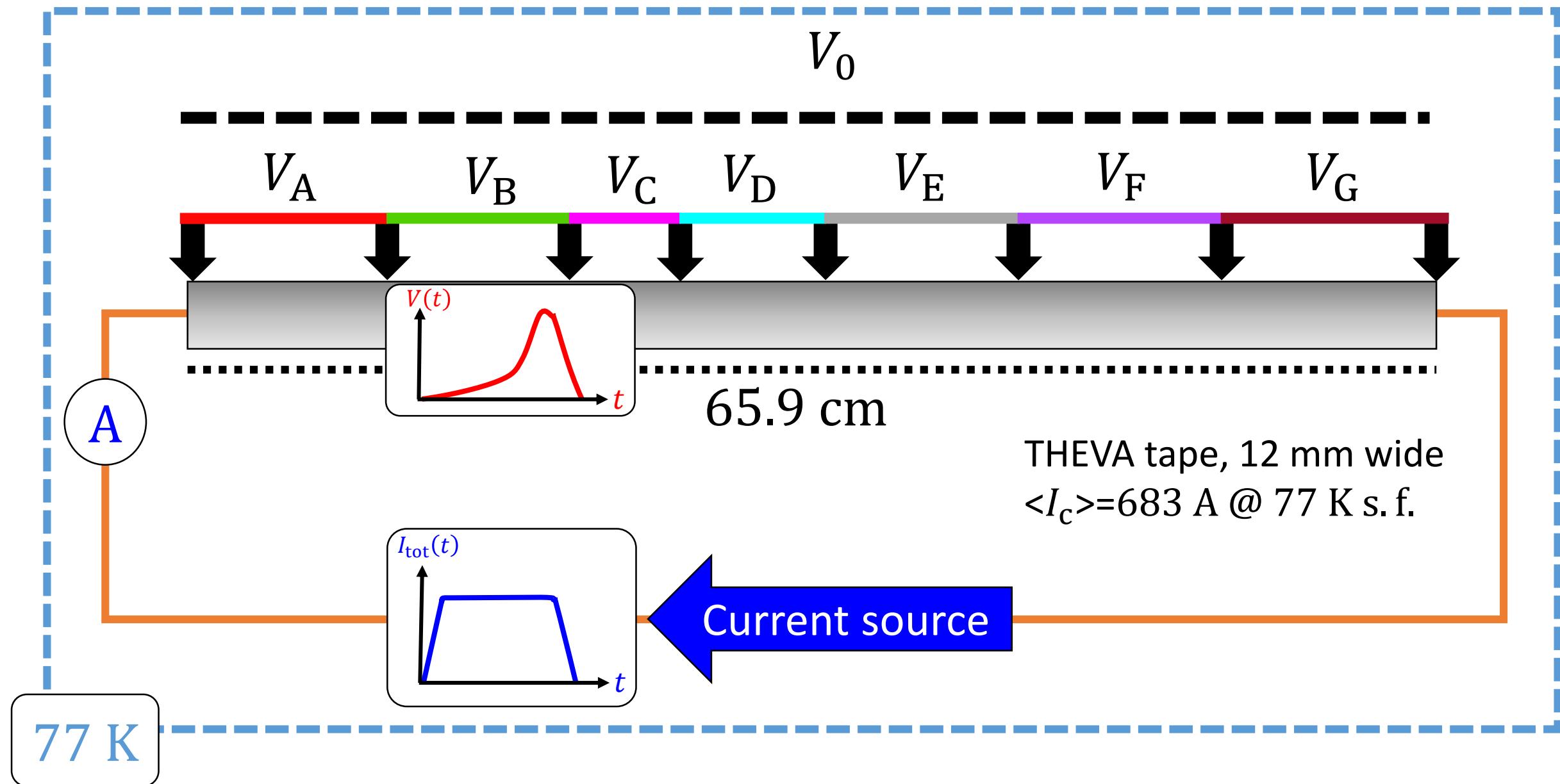
$$I_c(x) = \begin{cases} I_c(x_1) = 115 \text{ A} & x_1 < x < x_2 \\ I_c(x_2) = 110 \text{ A} & x_2 < x < x_3 \\ \dots \\ I_c(x_n) = 122 \text{ A} & x_{n-1} < x < x_n \end{cases}$$



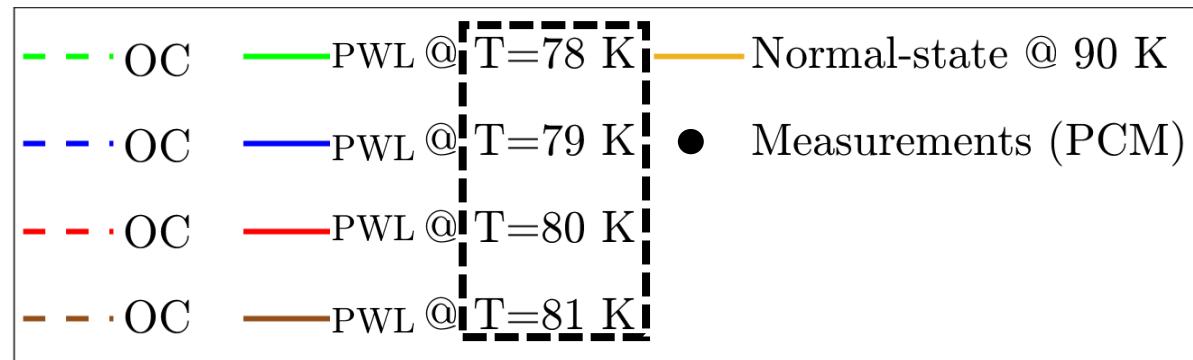
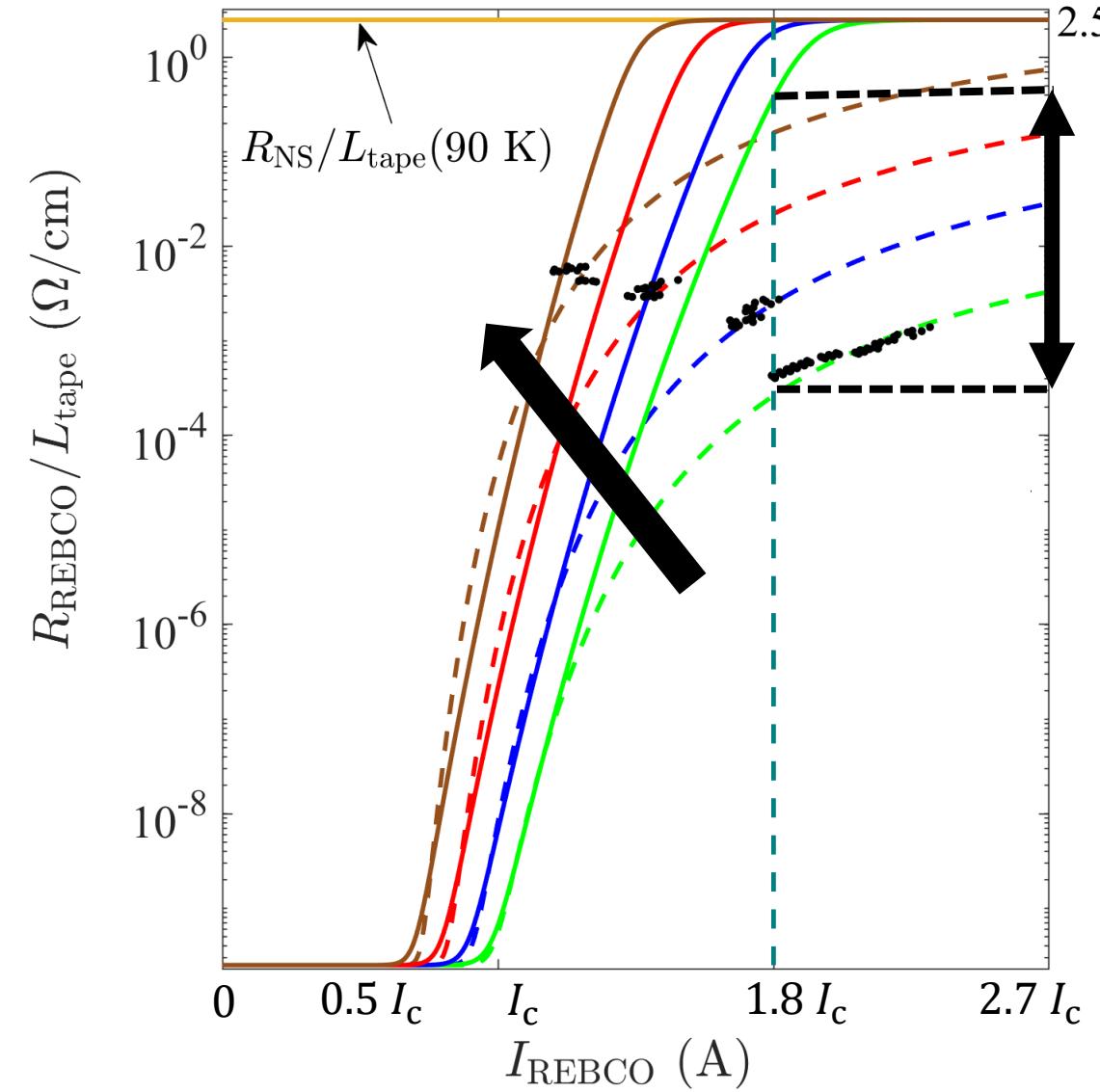
# Inhomogeneity implementation ( $n = 100$ resistors sections)



# Validation & results: experimental measurements



# Validation & results: Choice of the constitutive law (power law vs eta-beta law\*)



- Power-law

$$\rho_{\text{PWL}} = \rho_c \left( \frac{I}{I_c(T)} \right)^{n-1}$$

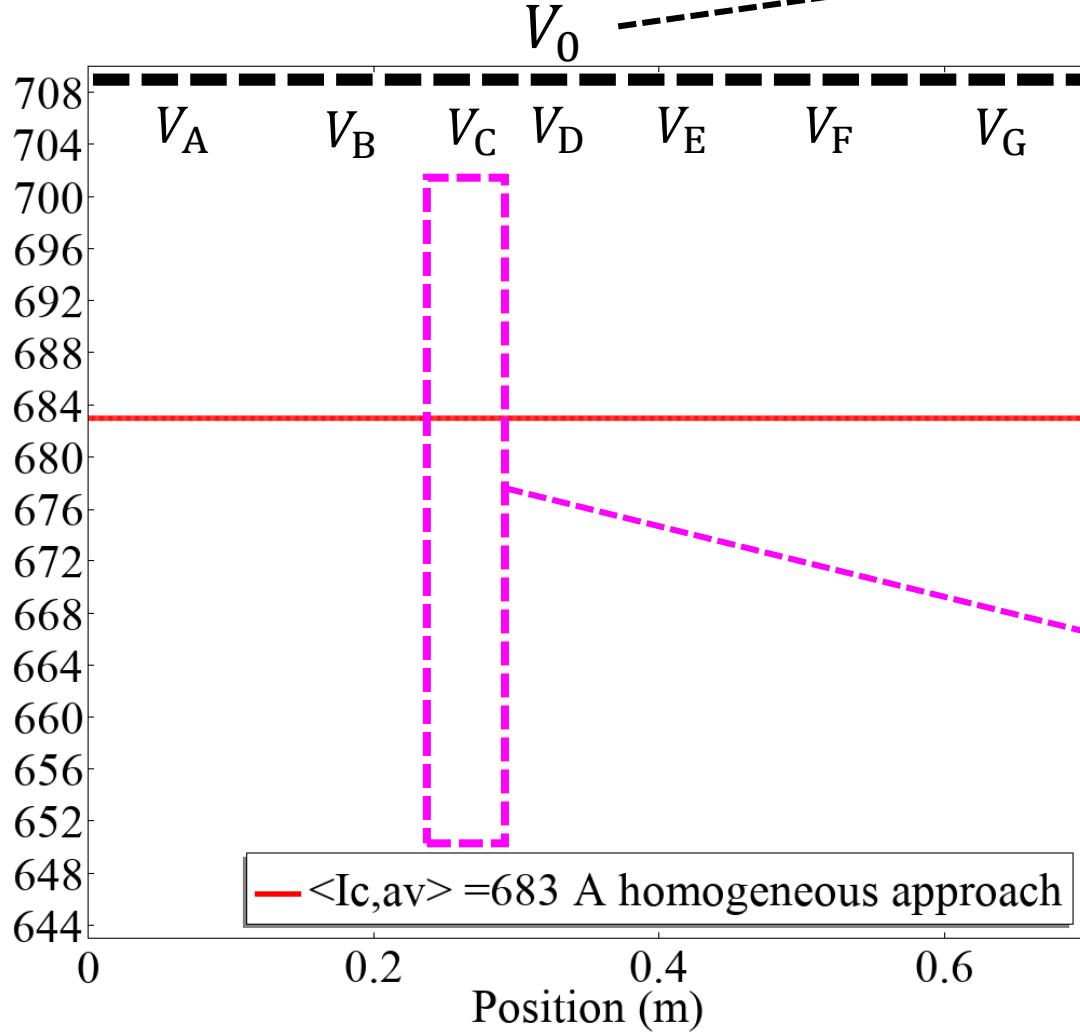
- Eta-beta law

$$\rho_{\eta\beta} = \rho_c e^{\left( \eta(T) \cdot \left[ 1 - \left( \frac{I_c(T)}{I} \right)^{\beta(T)} \right] \right)}$$

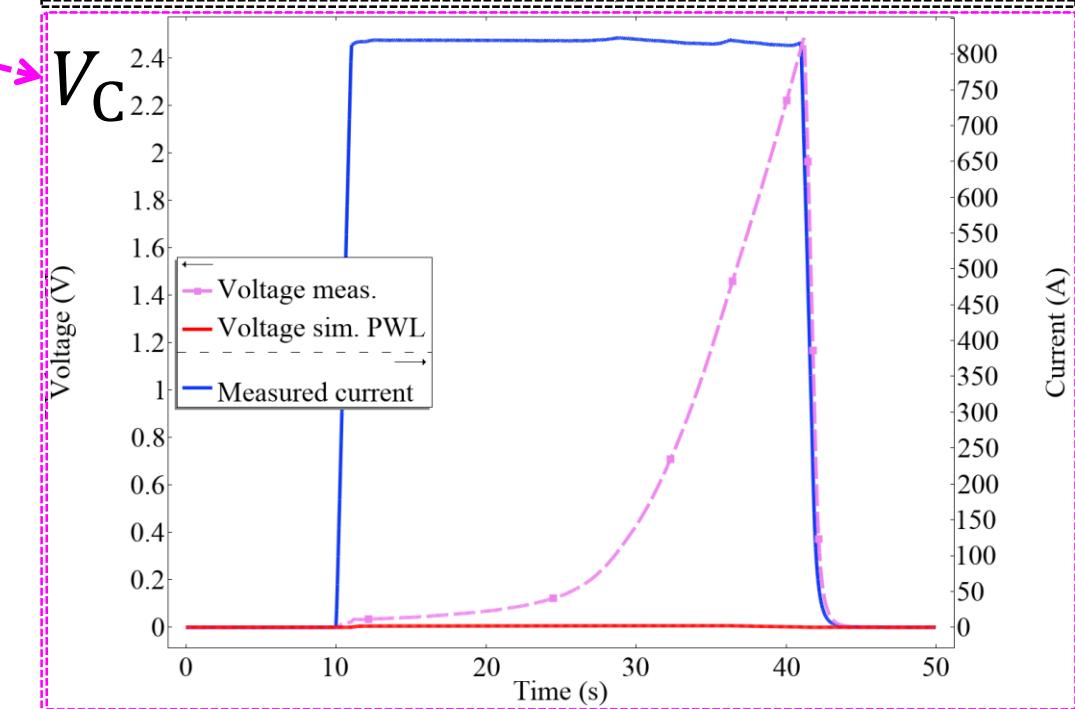
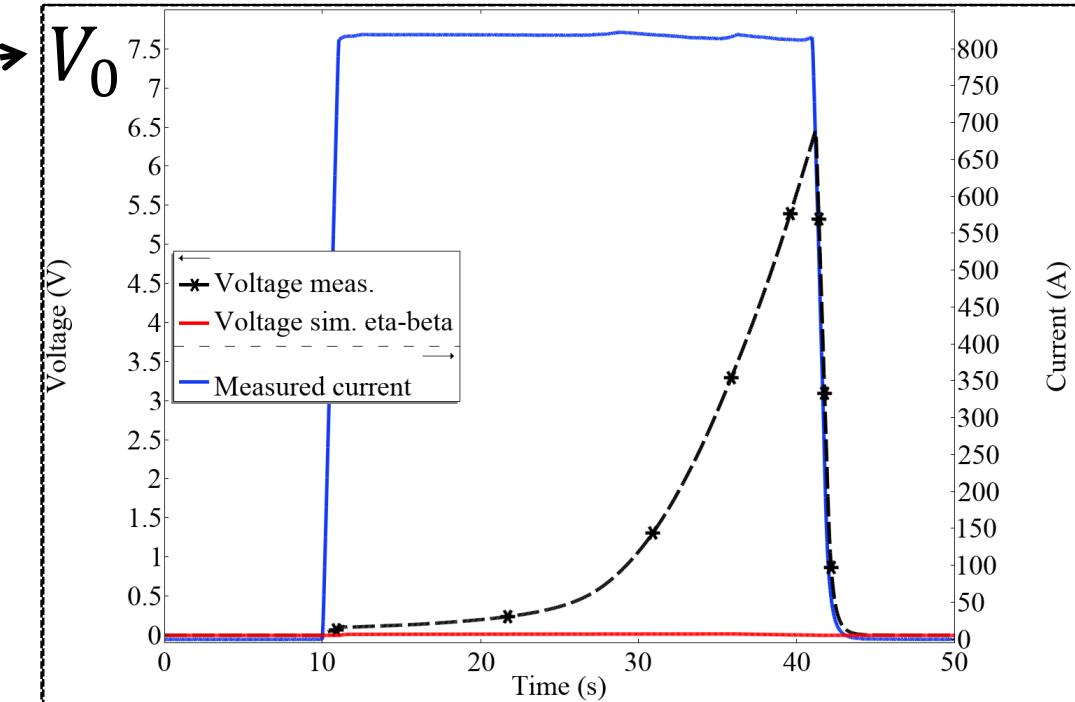
\*A wide range E – J constitutive law for simulating REBCO tapes above their critical current, N Riva, F Sirois, C Lacroix, F Pellerin, J Giguere, F Grilli and B Dutoit - SuST. 34 115014

# Voltage along the length (hom.)

Critical current distribution (A)

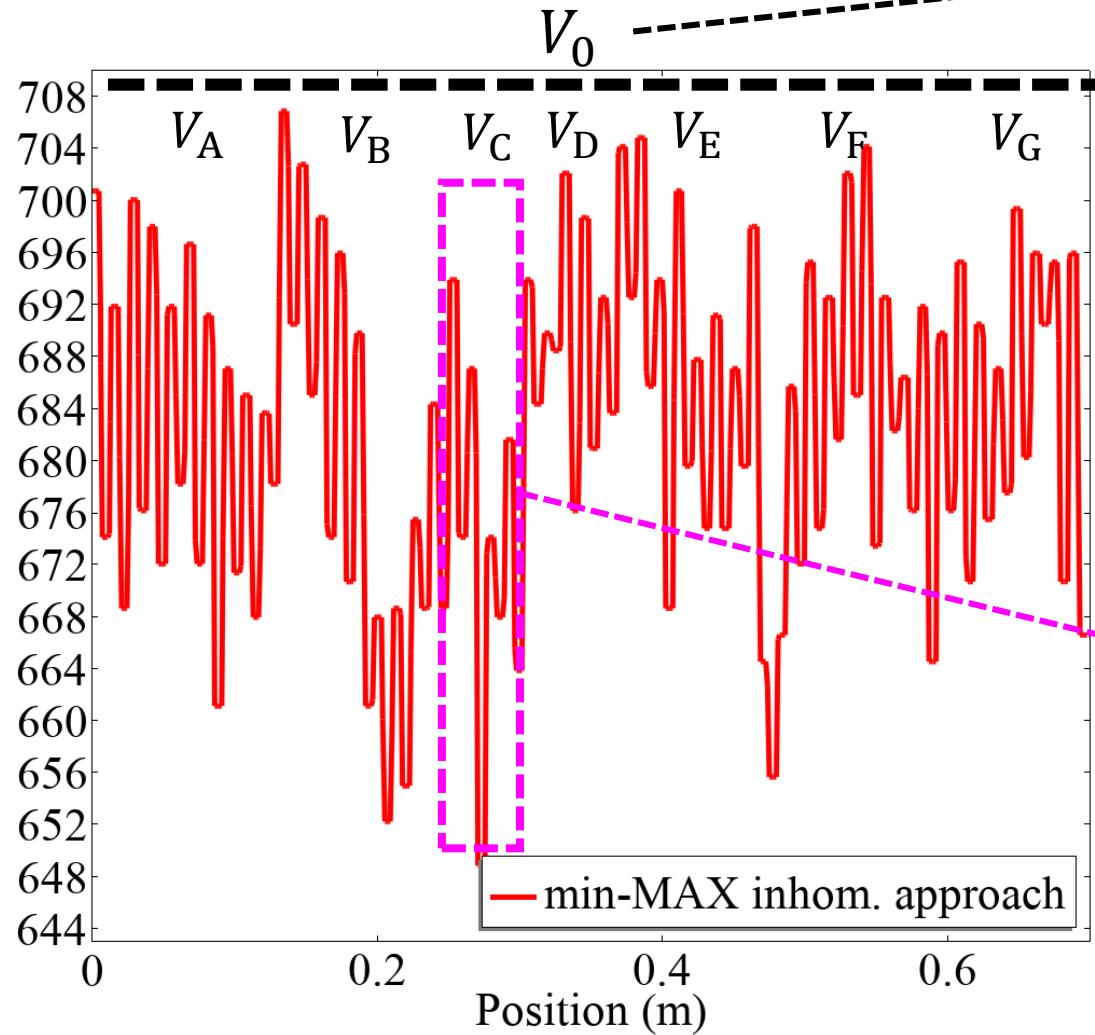


- 30 ms DC pulse  
@ $1.2 \cdot I_c = 820 \text{ A}$
- **Homogeneous  $I_c(x)$**

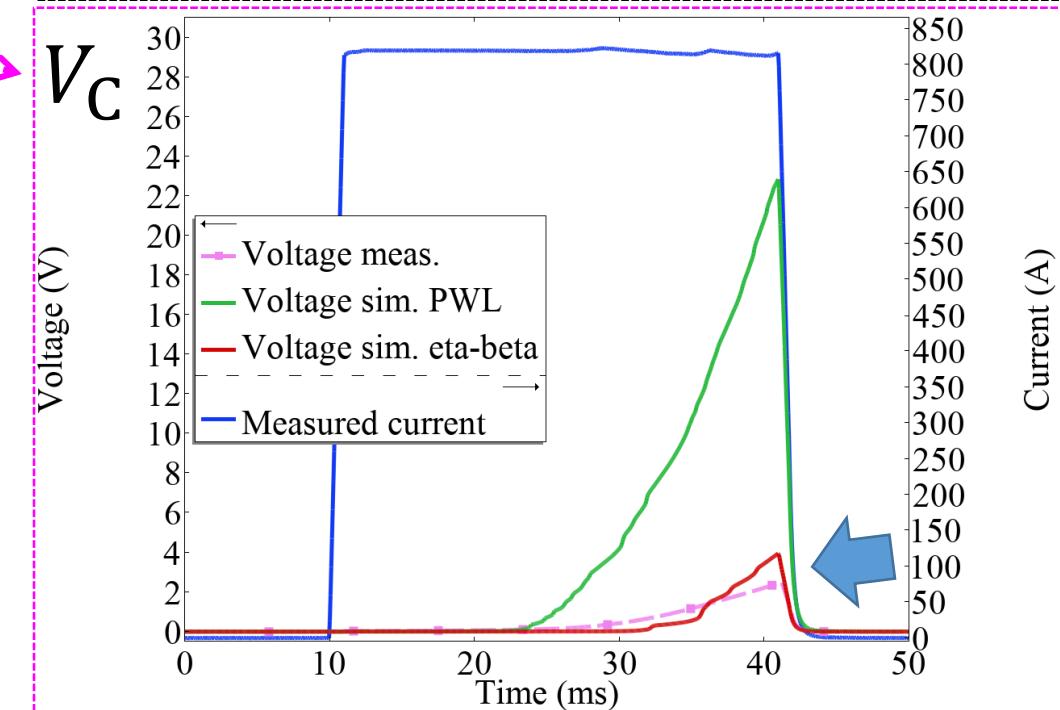
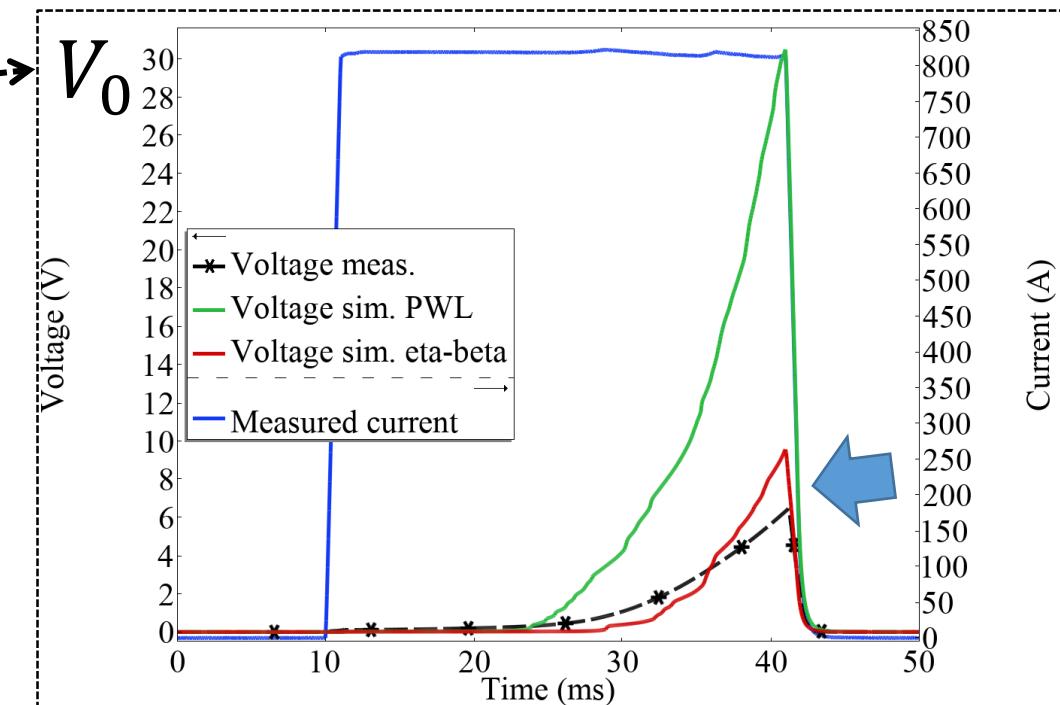


# Voltage along the length (inhom.)

Critical current distribution (A)

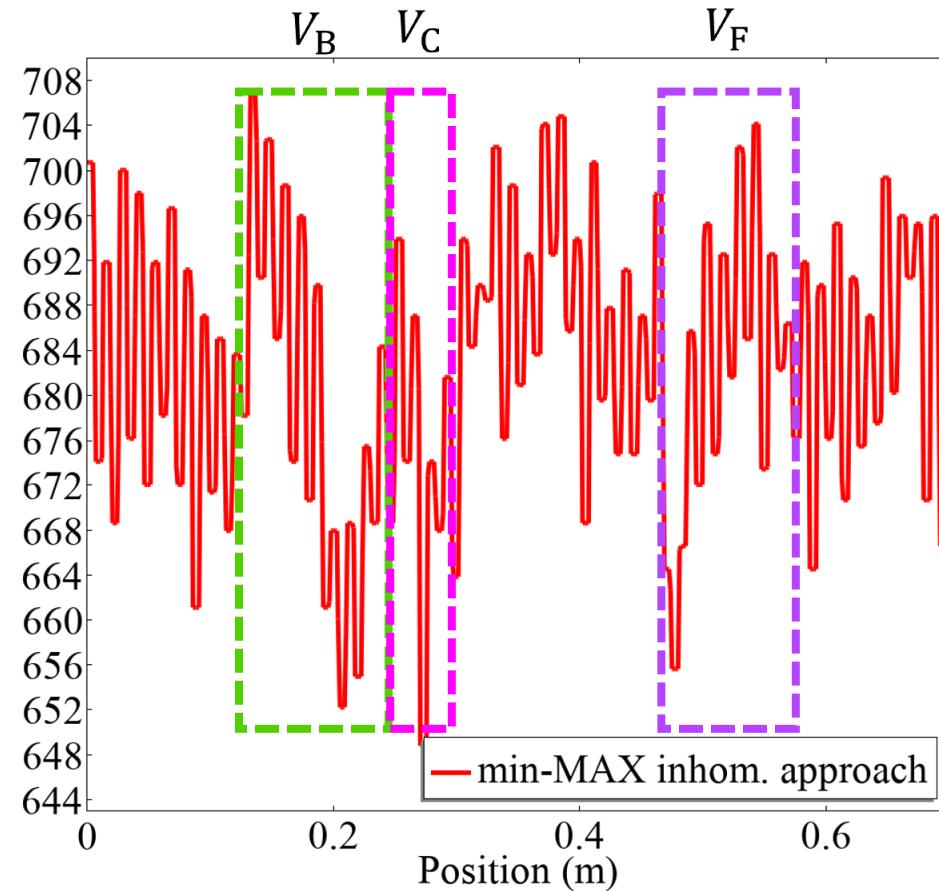


- 30 ms DC pulse  
@ $1.2 \cdot I_c = 820$  A
- **Inhomogeneous**  $I_c(x)$

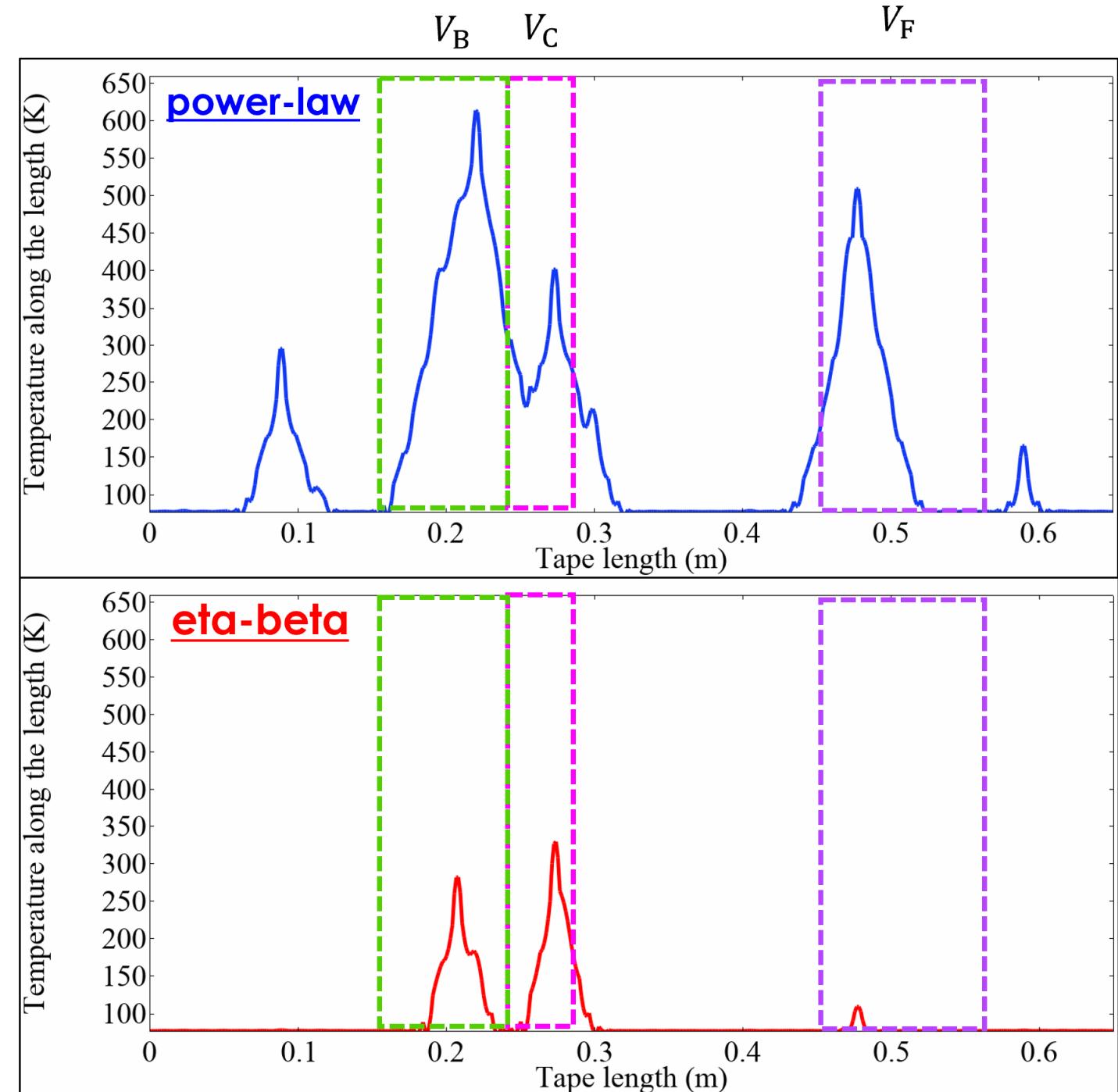


# Temperature profile (inhom.)

Critical current distribution (A)



- 30 ms DC pulse  
@ $1.2 \cdot I_c = 820$  A
- **Inhomogeneous**  $I_c(x)$



# Conclusions...



- 1) Inhomogeneous  $I_c(x)$  real data were used in a simple and computational efficient 1-D electrothermal model:
  - A. Homogeneous  $I_c(x)$  -> inaccurate simulations
  - B. Inhomogeneous  $I_c(x)$  -> **eta-beta law** better reproduces measurements than the **power-law** + realistic temperature profile along the tape length
- 2) Simple electrothermal model can be used to understand the role played in thermal runaways due to material inhomogeneity/defects

## ...and future work

- Improve agreement with measurements + further experiments
- Inhomogeneity layer thickness of materials (e.g., silver)
- Comparison with 2D/3D electrothermal models

